

Search Notes

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10/775,521

Examiner

Chun-Kuan (Mike) Lee

Applicant(s)/Patent under
Reexamination

NEMAZIE, SAM

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	2/8/2007	CHUN- KUAN Lee